

# PH3230S

N-channel TrenchMOS™ logic level FET

Rev. 03 — 02 March 2004

Product data

## 1. Product profile

### 1.1 Description

N-channel enhancement mode field-effect power transistor in a plastic package using TrenchMOS™ technology.

### 1.2 Features

- Logic level compatible
- High density mounting
- Low gate charge
- Very low on-state resistance.

### 1.3 Applications

- DC-to-DC converters
- Notebook computers
- Switched-mode power supplies
- Computer motherboards.

### 1.4 Quick reference data

- $V_{DS} \leq 30 \text{ V}$
- $I_D \leq 100 \text{ A}$
- $P_{tot} \leq 62.5 \text{ W}$
- $R_{DS(on)} \leq 3.2 \text{ m}\Omega$ .

## 2. Pinning information

Table 1: Pinning - SOT669 (LFAK), simplified outline and symbol

| Pin   | Description | Simplified outline                                 | Symbol        |
|-------|-------------|----------------------------------------------------|---------------|
| 1,2,3 | source (s)  | <p>Top view MBL286</p> <p><b>SOT669 (LFAK)</b></p> | <p>MBB076</p> |
| 4     | gate (g)    |                                                    |               |
| mb    | drain (d)   |                                                    |               |



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### 3. Ordering information

Table 2: Ordering information

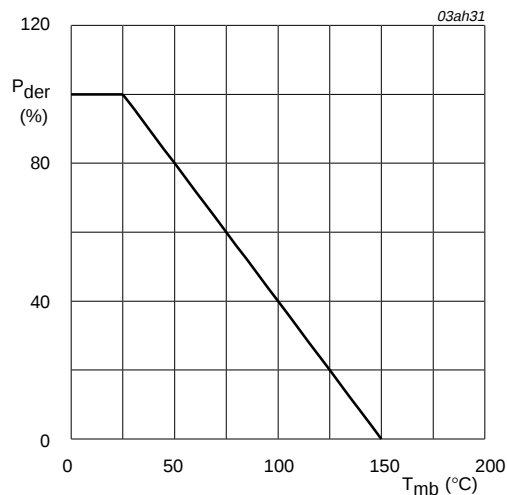
| Type number | Package |                                                       |         |
|-------------|---------|-------------------------------------------------------|---------|
|             | Name    | Description                                           | Version |
| PH3230S     | LFPAK   | Plastic single-ended surface mounted package, 4 leads | SOT669  |

### 4. Limiting values

Table 3: Limiting values

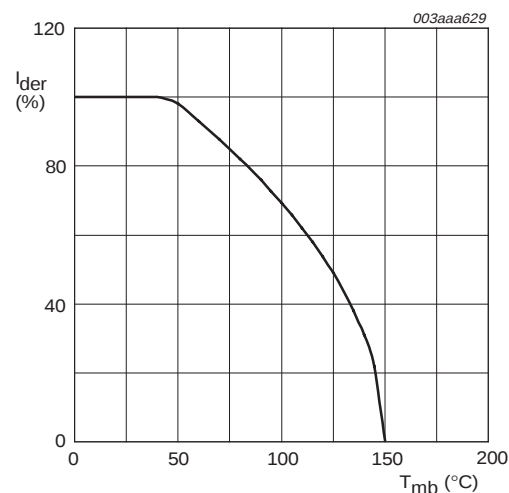
In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol                      | Parameter                                    | Conditions                                                                                                                                                       | Min | Max      | Unit |
|-----------------------------|----------------------------------------------|------------------------------------------------------------------------------------------------------------------------------------------------------------------|-----|----------|------|
| $V_{DS}$                    | drain-source voltage (DC)                    | $25\text{ °C} \leq T_j \leq 150\text{ °C}$                                                                                                                       | -   | 30       | V    |
| $V_{GS}$                    | gate-source voltage (DC)                     |                                                                                                                                                                  | -   | $\pm 20$ | V    |
| $I_D$                       | drain current (DC)                           | $T_{mb} = 25\text{ °C}$ ; $V_{GS} = 10\text{ V}$ ; <a href="#">Figure 2 and 3</a>                                                                                | -   | 100      | A    |
|                             |                                              | $T_{mb} = 100\text{ °C}$ ; $V_{GS} = 10\text{ V}$ ; <a href="#">Figure 2</a>                                                                                     | -   | 63       | A    |
| $I_{DM}$                    | peak drain current                           | $T_{mb} = 25\text{ °C}$ ; pulsed; $t_p \leq 10\text{ }\mu\text{s}$ ; <a href="#">Figure 3</a>                                                                    | -   | 300      | A    |
| $P_{tot}$                   | total power dissipation                      | $T_{mb} = 25\text{ °C}$ ; <a href="#">Figure 1</a>                                                                                                               | -   | 62.5     | W    |
| $T_{stg}$                   | storage temperature                          |                                                                                                                                                                  | -55 | +150     | °C   |
| $T_j$                       | junction temperature                         |                                                                                                                                                                  | -55 | +150     | °C   |
| <b>Source-drain diode</b>   |                                              |                                                                                                                                                                  |     |          |      |
| $I_S$                       | source (diode forward) current (DC)          | $T_{mb} = 25\text{ °C}$                                                                                                                                          | -   | 52       | A    |
| $I_{SM}$                    | peak source (diode forward) current          | $T_{mb} = 25\text{ °C}$ ; pulsed; $t_p \leq 10\text{ }\mu\text{s}$                                                                                               | -   | 156      | A    |
| <b>Avalanche ruggedness</b> |                                              |                                                                                                                                                                  |     |          |      |
| $E_{DS(AL)R}$               | repetitive drain-source avalanche energy     | $T_j = 25\text{ °C}$ ; $R_{GS} \geq 50\text{ }\Omega$ ; $I_{DS(AL)R} = 5\text{ A}$ ; $V_{DD} = 15\text{ V}$ ; duty < 0.1%                                        | -   | 2.5      | mJ   |
| $E_{DS(AL)S}$               | non-repetitive drain-source avalanche energy | unclamped inductive load; $I_D = 50\text{ A}$ ; $V_{DD} \leq 15\text{ V}$ ; $R_{GS} = 50\text{ }\Omega$ ; $V_{GS} = 10\text{ V}$ ; starting $T_j = 25\text{ °C}$ | -   | 250      | mJ   |



$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}\text{C})}} \times 100\%$$

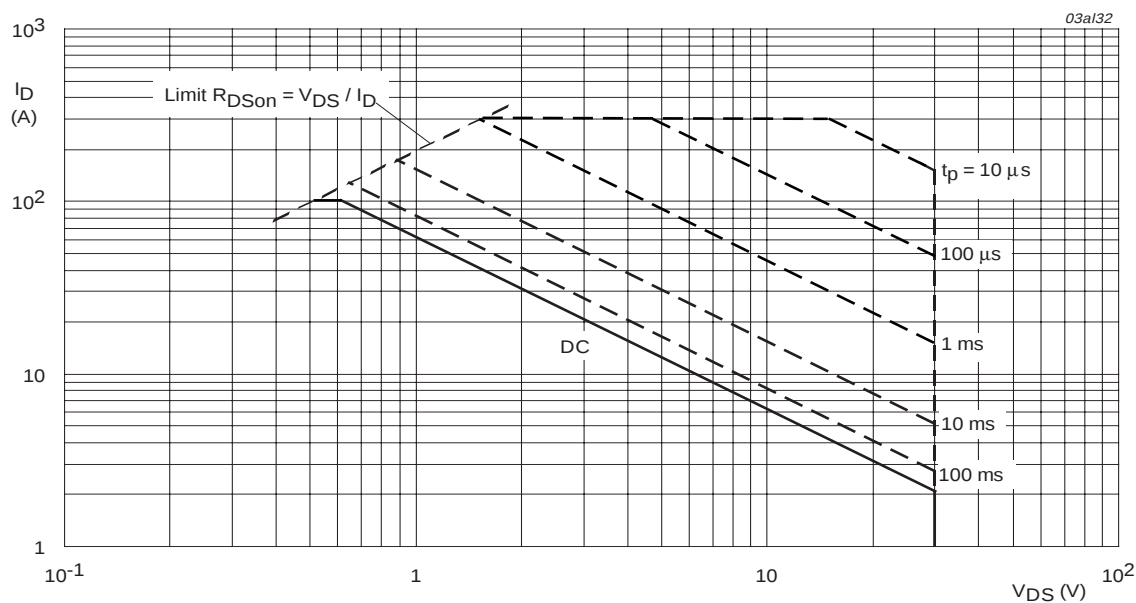
**Fig 1. Normalized total power dissipation as a function of mounting base temperature.**



$$V_{GS} \geq 10 \text{ V}$$

$$I_{der} = \frac{I_D}{I_{D(25^{\circ}\text{C})}} \times 100\%$$

**Fig 2. Normalized continuous drain current as a function of mounting base temperature.**



$T_{mb} = 25^{\circ}\text{C}$ ;  $I_{DM}$  is single pulse.

**Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage.**

5. Thermal characteristics

Table 4: Thermal characteristics

| Symbol         | Parameter                                         | Conditions | Min | Typ | Max | Unit |
|----------------|---------------------------------------------------|------------|-----|-----|-----|------|
| $R_{th(j-mb)}$ | thermal resistance from junction to mounting base | Figure 4   | -   | -   | 2   | K/W  |

5.1 Transient thermal impedance

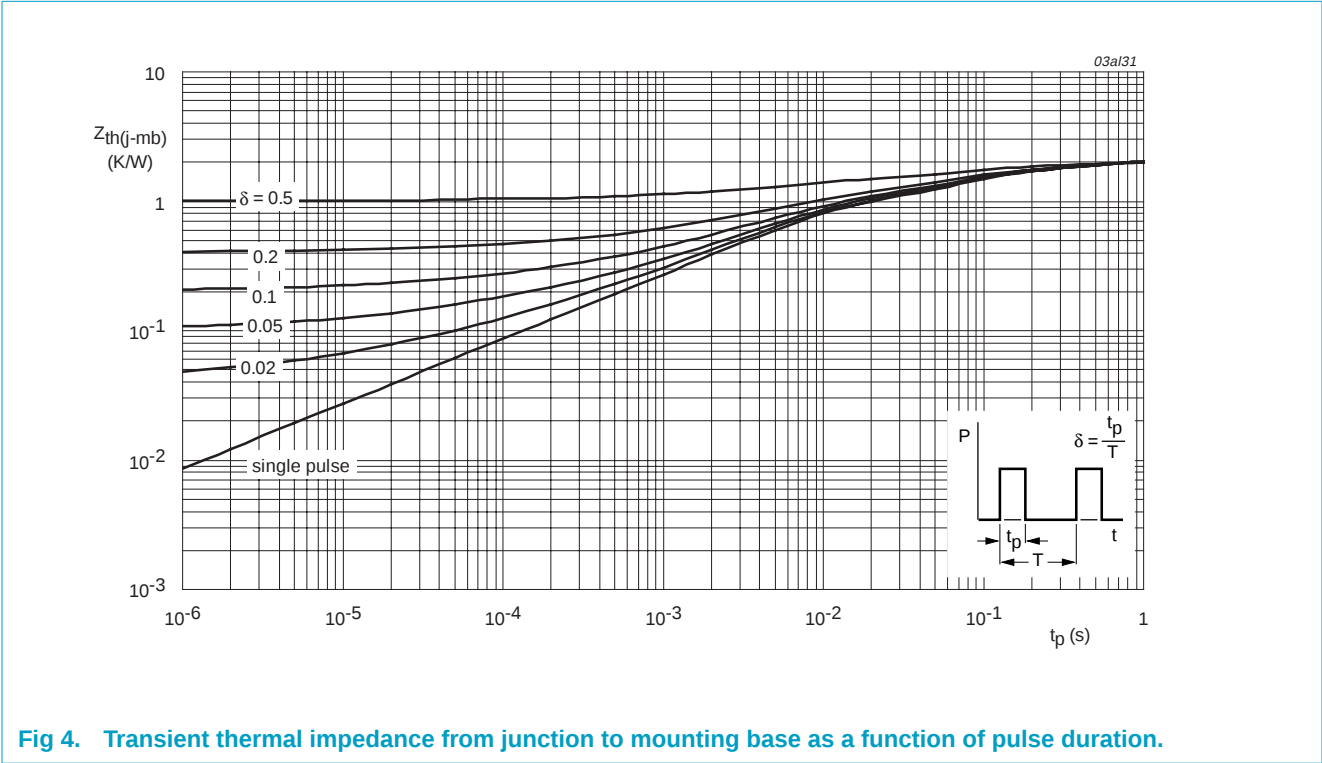


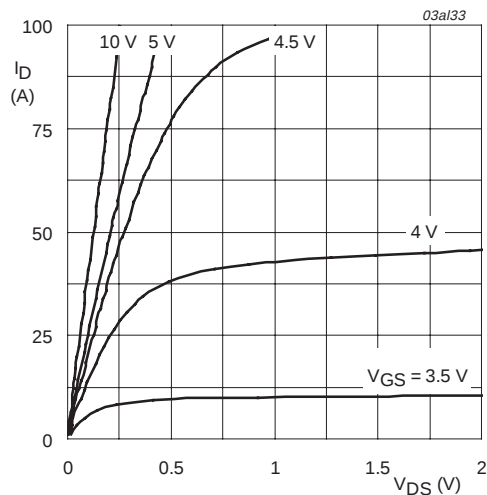
Fig 4. Transient thermal impedance from junction to mounting base as a function of pulse duration.

## 6. Characteristics

**Table 5: Characteristics**

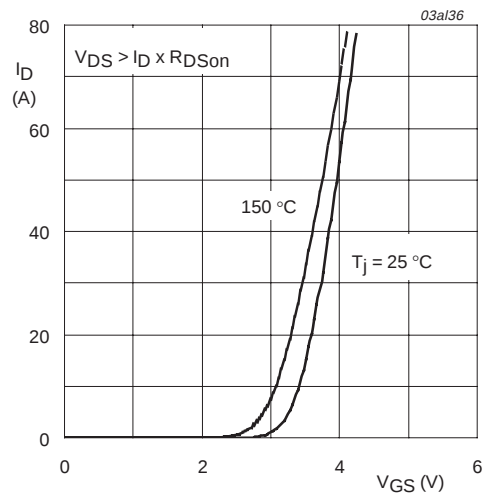
$T_J = 25^\circ\text{C}$  unless otherwise specified.

| Symbol                       | Parameter                            | Conditions                                                                                    | Min                                                                        | Typ  | Max  | Unit |
|------------------------------|--------------------------------------|-----------------------------------------------------------------------------------------------|----------------------------------------------------------------------------|------|------|------|
| Static characteristics       |                                      |                                                                                               |                                                                            |      |      |      |
| V <sub>(BR)DSS</sub>         | drain-source breakdown voltage       | I <sub>D</sub> = 10 mA; V <sub>GS</sub> = 0 V                                                 | 30                                                                         | -    | -    | V    |
| V <sub>GS(th)</sub>          | gate-source threshold voltage        | I <sub>D</sub> = 1 mA; V <sub>DS</sub> = V <sub>GS</sub> ; <b>Figure 9</b>                    | 1                                                                          | 2    | 3    | V    |
| I <sub>DSS</sub>             | drain-source leakage current         | V <sub>DS</sub> = 30 V; V <sub>GS</sub> = 0 V                                                 | -                                                                          | -    | 1    | μA   |
| I <sub>GSS</sub>             | gate-source leakage current          | V <sub>GS</sub> = ±20 V; V <sub>DS</sub> = 0 V                                                | -                                                                          | 10   | 100  | nA   |
| R <sub>DSon</sub>            | drain-source on-state resistance     | V <sub>GS</sub> = 10 V; I <sub>D</sub> = 25 A; <b>Figure 7 and 8</b>                          | -                                                                          | 2.7  | 3.2  | mΩ   |
|                              |                                      | V <sub>GS</sub> = 4.5 V; I <sub>D</sub> = 25 A; <b>Figure 8</b>                               | -                                                                          | 5.0  | 6.5  | mΩ   |
| Dynamic characteristics      |                                      |                                                                                               |                                                                            |      |      |      |
| g <sub>fs</sub>              | forward transconductance             | V <sub>DS</sub> = 10 V; I <sub>D</sub> = 25 A; <b>Figure 11</b>                               | 39                                                                         | 75   | -    | S    |
| Q <sub>g(tot)</sub>          | total gate charge                    | I <sub>D</sub> = 50 A; V <sub>DD</sub> = 10 V; V <sub>GS</sub> = 5 V; <b>Figure 14</b>        | -                                                                          | 42   | -    | nC   |
| Q <sub>gs</sub>              | gate-source charge                   |                                                                                               | -                                                                          | 21   | -    | nC   |
| Q <sub>gd</sub>              | gate-drain (Miller) charge           |                                                                                               | -                                                                          | 13   | -    | nC   |
| C <sub>iss</sub>             | input capacitance                    |                                                                                               | V <sub>GS</sub> = 0 V; V <sub>DS</sub> = 10 V; f = 1 MHz; <b>Figure 12</b> | -    | 4100 | -    |
| C <sub>oss</sub>             | output capacitance                   | -                                                                                             |                                                                            | 1150 | -    | pF   |
| C <sub>rss</sub>             | reverse transfer capacitance         | -                                                                                             |                                                                            | 750  | -    | pF   |
| t <sub>d(on)</sub>           | turn-on delay time                   | V <sub>DD</sub> = 10 V; I <sub>D</sub> = 25 A; V <sub>GS</sub> = 10 V; R <sub>G</sub> = 4.7 Ω | -                                                                          | 14   | -    | ns   |
| t <sub>r</sub>               | rise time                            |                                                                                               | -                                                                          | 37   | -    | ns   |
| t <sub>d(off)</sub>          | turn-off delay time                  |                                                                                               | -                                                                          | 85   | -    | ns   |
| t <sub>f</sub>               | fall time                            |                                                                                               | -                                                                          | 37   | -    | ns   |
| Source-drain (reverse) diode |                                      |                                                                                               |                                                                            |      |      |      |
| V <sub>SD</sub>              | source-drain (diode forward) voltage | I <sub>S</sub> = 25 A; V <sub>GS</sub> = 0 V; <b>Figure 13</b>                                | -                                                                          | 0.8  | 1.2  | V    |
| t <sub>rr</sub>              | reverse recovery time                | I <sub>S</sub> = 20 A; dI <sub>S</sub> /dt = −50 A/μs; V <sub>GS</sub> = 0 V                  | -                                                                          | 46   | -    | ns   |



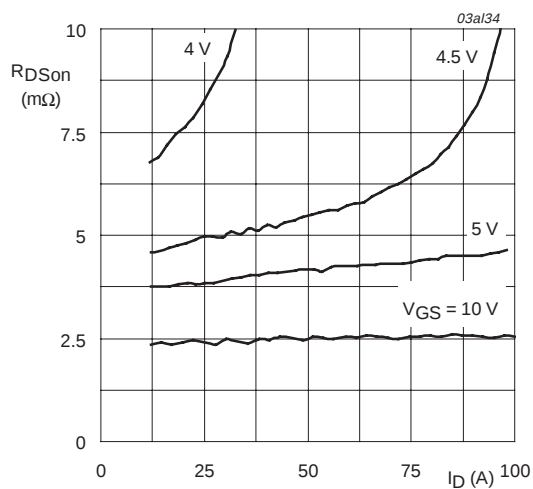
$T_j = 25\text{ }^{\circ}\text{C}$

**Fig 5.** Output characteristics: drain current as a function of drain-source voltage; typical values.



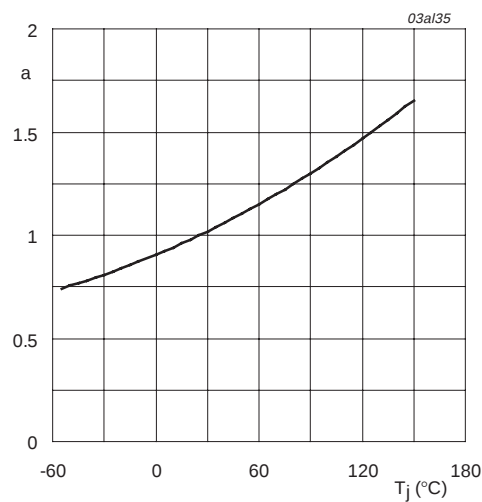
$T_j = 25\text{ }^{\circ}\text{C}$  and  $150\text{ }^{\circ}\text{C}$ ;  $V_{DS} > I_D \times R_{DSon}$

**Fig 6.** Transfer characteristics: drain current as a function of gate-source voltage; typical values.



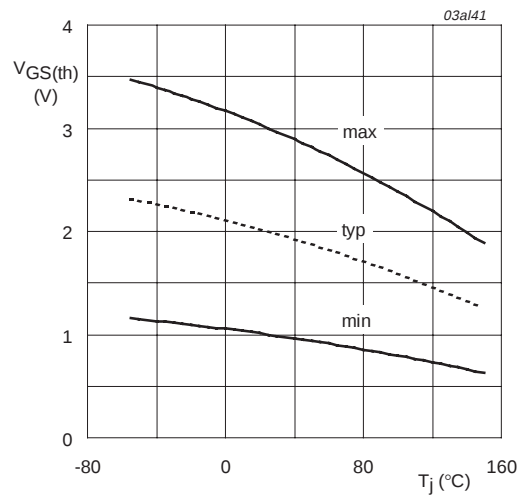
$T_j = 25\text{ }^{\circ}\text{C}$

**Fig 7.** Drain-source on-state resistance as a function of drain current; typical values.



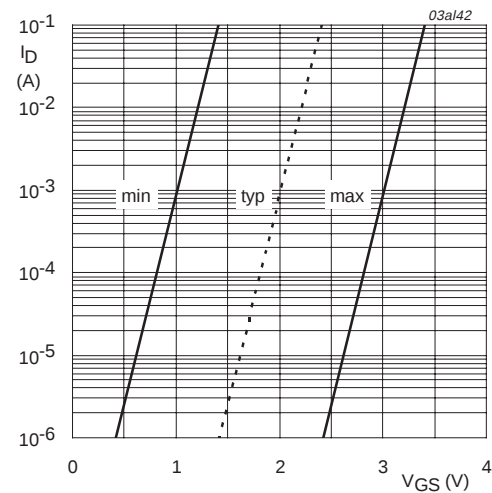
$$a = \frac{R_{DSon}}{R_{DSon(25^{\circ}\text{C})}}$$

**Fig 8.** Normalized drain-source on-state resistance factor as a function of junction temperature.



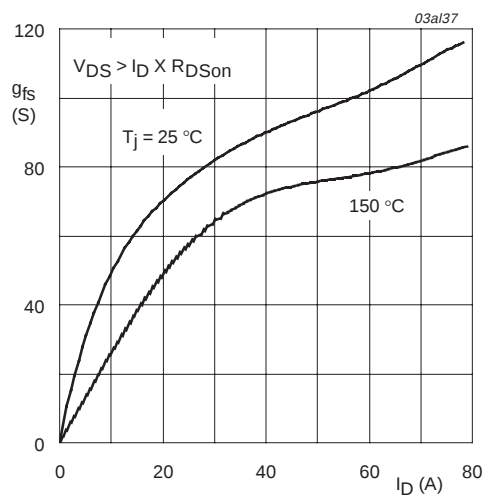
$I_D = 1 \text{ mA}$ ;  $V_{DS} = V_{GS}$

**Fig 9. Gate-source threshold voltage as a function of junction temperature**



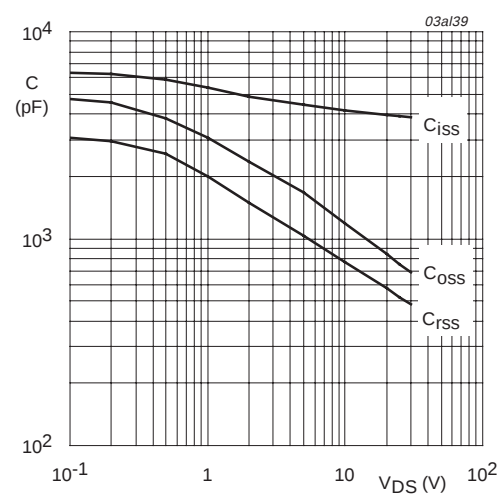
$T_J = 25 \text{ °C}$

**Fig 10. Sub-threshold drain current as a function of gate-source voltage.**



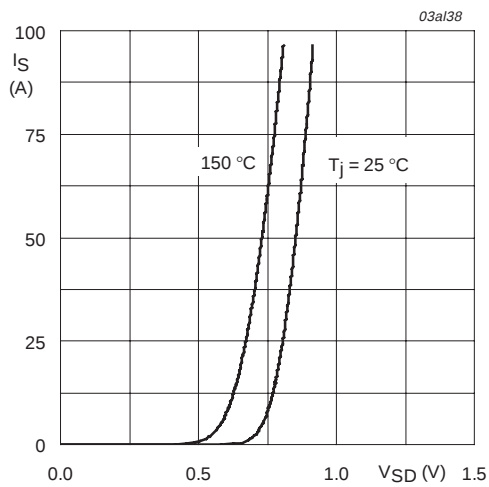
$T_J = 25 \text{ °C}$  and  $150 \text{ °C}$ ;  $V_{DS} > I_D \times R_{DS(on)}$

**Fig 11. Forward transconductance as a function of drain current; typical values.**



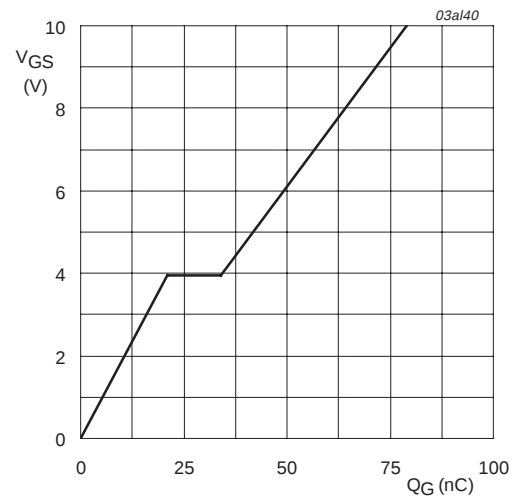
$V_{GS} = 0 \text{ V}$ ;  $f = 1 \text{ MHz}$

**Fig 12. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values.**



$T_J = 25\text{ °C}$  and  $150\text{ °C}$ ;  $V_{GS} = 0\text{ V}$

**Fig 13. Source (diode forward) current as a function of source-drain (diode forward) voltage; typical values.**



$T_J = 25\text{ °C}$ ;  $I_D = 50\text{ A}$ ;  $V_{DD} = 10\text{ V}$

**Fig 14. Gate-source voltage as a function of gate charge; typical values.**

7. Package outline

Plastic single-ended surface mounted package (Philips version LFAK); 4 leads

SOT669

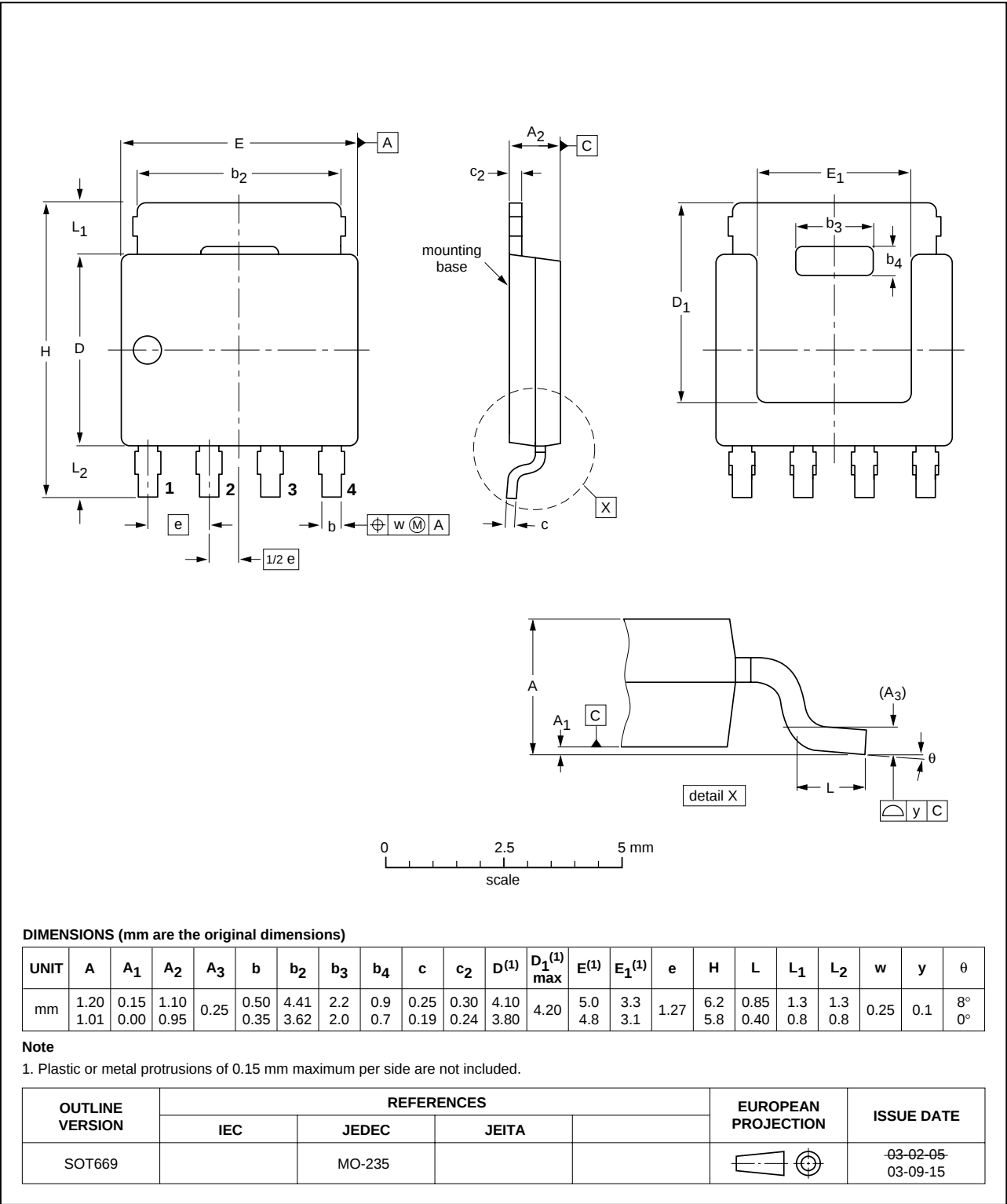


Fig 15. SOT669 (LFAK).

## 8. Revision history

Table 6: Revision history

| Rev | Date     | CPCN | Description                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                        |
|-----|----------|------|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 03  | 20040302 | -    | <b>Product data (9397 750 12756)</b><br>Modifications: <ul style="list-style-type: none"> <li>• <math>I_D</math> data corrected in <a href="#">Section 1.4 “Quick reference data”</a></li> <li>• <math>g_{fs}</math> typical value modified <a href="#">Table 5 “Characteristics”</a></li> <li>• <math>V_{SD}</math> condition and typical values modified <a href="#">Table 5 “Characteristics”</a></li> <li>• <math>t_{rr}</math> condition modified <a href="#">Table 5 “Characteristics”</a></li> <li>• <math>t_r</math> and <math>t_f</math> data corrected in <a href="#">Table 5 “Characteristics”</a></li> <li>• <math>I_S</math> data added in <a href="#">Table 3 “Limiting values”</a></li> <li>• <math>I_{SM}</math>, <math>I_D</math> and <math>I_{DM}</math> data corrected in <a href="#">Table 3 “Limiting values”</a></li> <li>• Correction to <a href="#">Figure 2</a> and <a href="#">Figure 3</a></li> <li>• <a href="#">Section 3 “Ordering information”</a> added</li> </ul> |
| 02  | 20030423 | -    | <b>Product data (9397 750 11279)</b><br>Modifications: <ul style="list-style-type: none"> <li>• Avalanche ruggedness data added in <a href="#">Table 3</a></li> <li>• Correction to <a href="#">Figure 6</a></li> <li>• Correction to <a href="#">Figure 11</a></li> <li>• Correction to <a href="#">Figure 13</a></li> </ul>                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                      |
| 01  | 20030212 | -    | <b>Preliminary data (9397 750 11078)</b>                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                           |

## 9. Data sheet status

| Level | Data sheet status <sup>[1]</sup> | Product status <sup>[2][3]</sup> | Definition                                                                                                                                                                                                                                                                                     |
|-------|----------------------------------|----------------------------------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| I     | Objective data                   | Development                      | This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.                                                                                                    |
| II    | Preliminary data                 | Qualification                    | This data sheet contains data from the preliminary specification. Supplementary data will be published at a later date. Philips Semiconductors reserves the right to change the specification without notice, in order to improve the design and supply the best possible product.             |
| III   | Product data                     | Production                       | This data sheet contains data from the product specification. Philips Semiconductors reserves the right to make changes at any time in order to improve the design, manufacturing and supply. Relevant changes will be communicated via a Customer Product/Process Change Notification (CPCN). |

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[2] The product status of the device(s) described in this data sheet may have changed since this data sheet was published. The latest information is available on the Internet at URL <http://www.semiconductors.philips.com>.

[3] For data sheets describing multiple type numbers, the highest-level product status determines the data sheet status.

## 10. Definitions

**Short-form specification** — The data in a short-form specification is extracted from a full data sheet with the same type number and title. For detailed information see the relevant data sheet or data handbook.

**Limiting values definition** — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 60134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

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Fax: +31 40 27 24825

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